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# A 180 nm Self-biased Bandgap Reference with High PSRR Enhancement

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## Abstract

In this paper, an improved self-biased bandgap reference (BGR) with high power supply rejection ratio (PSRR) is presented. An operational amplifier constructing feedback loop is multiplexed with the generation of positive temperature coefficient (TC) voltage for lower power consumption, where an offset voltage is adopted to achieve proportional to absolute temperature (PTAT) voltage. With the temperature-independent reference generation, two feedback loops are realized at the same time for PSRR enhancement, which form a local negative feedback loop (LNFL) and a global self-biased loop (GSBL). The proposed BGR is implemented in a 180 nm BCD technology, whose results show that the generated reference voltage is 2.506 V, and the TC is 25 ppm/°C in the temperature range of −55 to 125 °C. The line sensitivity (LS) is 0.08 %/V. Without any filter capacitor, the PSRR is 76 dB at low frequencies, over 46 dB up to 1 MHz.

**Keywords:** Global self-biased loop, Local negative feedback loop, High power supply rejection ratio

## Introduction

Voltage reference is one of the core modules in electronic systems, which is widely used in medical electronics, power managements, wireless environmental sensors, and communication circuits. With the improvement of technology, the area of chip continues to shrink, and the anti-interference ability continues to increase, and the requirements for structural optimization and noise immunity of voltage reference are increasing dramatically, especially in nanoscale applications [1].

Conventional bandgap reference (BGR) circuits require additional circuit blocks to provide bias current for the entire circuit, which greatly increases the circuit area and power consumption. At the same time, the generated bias current is greatly affected by temperature, which affects the temperature coefficient (TC) of the reference voltage. Lots of high-order compensated techniques for improved TC have been reported, such as piecewise curvature compensation [2], exponential curvature compensation [3], leakage-based square root

compensation (LSRC) [4], and so on. Another disadvantage of the conventional BGR circuit is that it is greatly affected by the external environment and the output voltage is unstable, which is the focus of this article.

Power supply rejection ratio (PSRR) is an important parameter to measure the noise immunity of a voltage reference. Conventional solutions to improve PSRR are at the cost of chip area and power consumption [5], such as additional amplifiers, long channel transistors, cascode structures [6], additional gain stage [7], and so on. Active attenuator and impedance adapting compensation were adopted in [8] to improve the PSRR at low and high frequencies, respectively. Yue et al. [9] used cascode current mirrors to enhance PSRR. Body bias and negative feedback techniques were utilized in [10] for high PSRR.

In order to overcome the above-mentioned issues, an improved self-biased BGR with high PSRR is proposed in this brief. Two feedback loops are realized at the same time for PSRR enhancement, which form a local negative feedback loop (LNFL) and a global self-biased loop (GSBL). Meanwhile, a self-bias current source (SBCS) for the whole BGR is achieved. At steady state, the proposed BGR is self-powered through the GSBL without additional bias current modules and chip area. The

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presented technique separates the supply voltage from the output reference voltage through a current amplifier embedded in GSBL, which can effectively improve the PSRR. In addition, in order to prevent the output voltage from instability, a LNFL is designed at the output voltage terminal to keep the output voltage stable. What is more, the temperature-stable reference voltage is generated with LNFL and GSBL in a multiplexing way. With these methods, a self-biased BGR with high PSRR enhancement is implemented with compacted structure and current consumption.

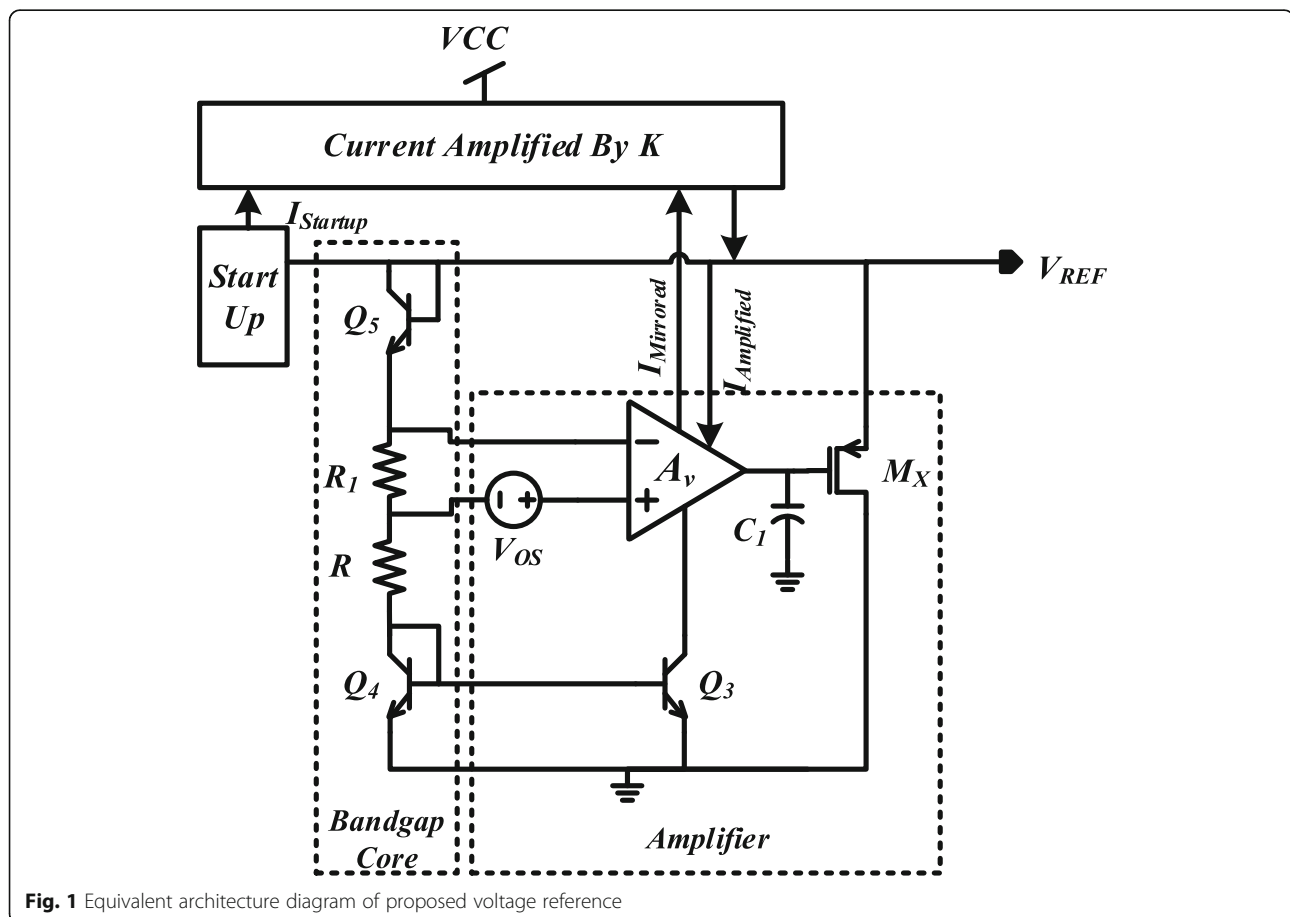
## Method

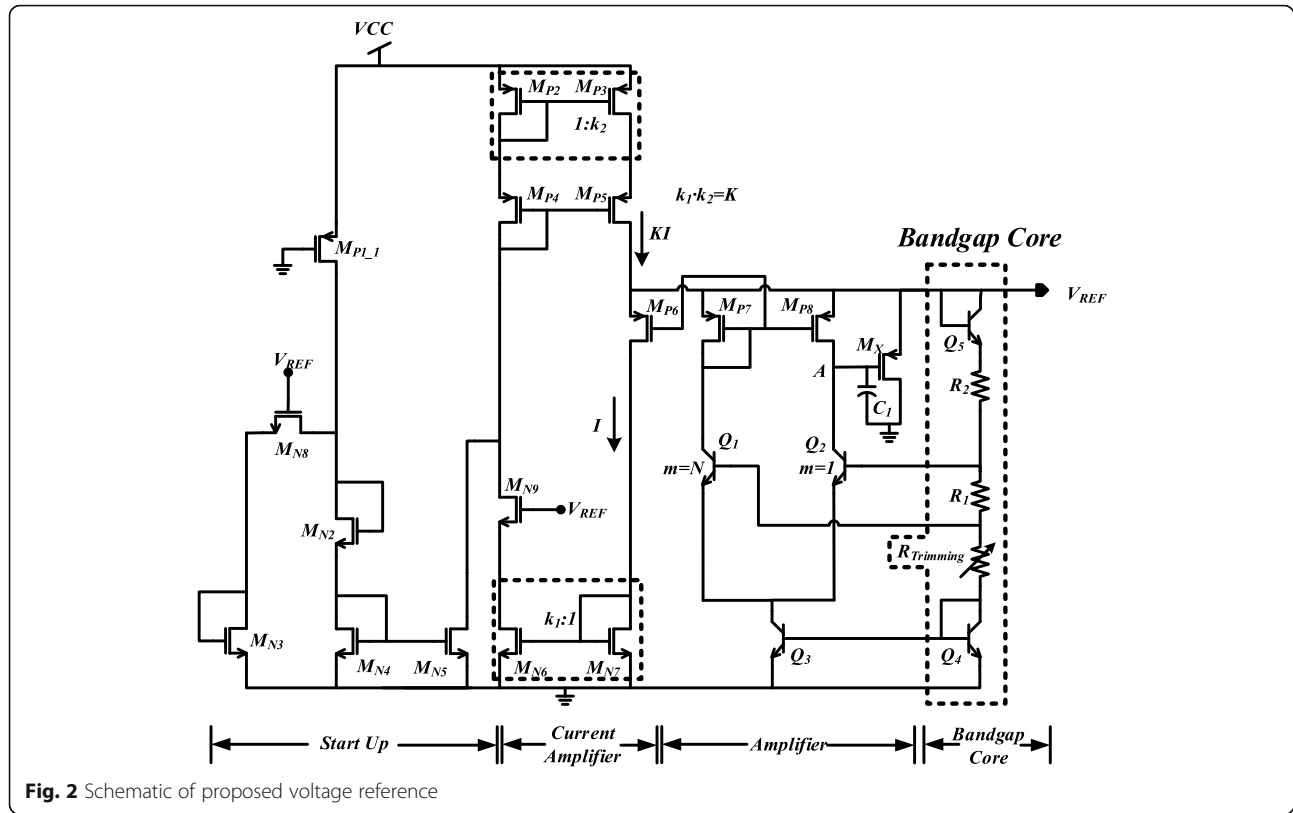
As shown in Fig. 1, the proposed BGR circuit consists of a start-up circuit, a current amplifier, an operational amplifier, and a bandgap reference core. The start-up circuit is used to get rid of the zero-degenerate point. The built-in offset voltage in the amplifier is set to be proportional to absolute temperature (PTAT) voltage, which can realize a PTAT current through resistor  $R_1$ . With the positive TC of voltage across  $R_1$  and  $R_2$ , the negative TC of  $V_{BE(Q5)}$  and  $V_{BE(Q4)}$  can be properly canceled to achieve a temperature-stable reference voltage at node  $V_{REF}$ . At the same time, a LNFL formed with the

help of an amplifier to improve the performance. Combined with the current amplifier on the top of Fig. 1, a GSBL is realized for further PSRR improvement. The detail implementation of the proposed BGR is shown in Fig. 2.

## Start-up Circuit

The start-up circuit is shown in the left part of Fig. 2. At the beginning of the start-up stage, output voltage  $V_{REF}$  is at low level, which keeps MN8 and MN9 off. The current through MP1\_1 is used to generate a start-up current to MP5, where MP1\_1 is as a large resistance with quite small aspect ratio. The voltage at  $V_{REF}$  will be gradually charged by the start-up current. When the voltage at  $V_{REF}$  exceeds the minimum operation voltage of the bandgap core part, the bias current for the amplifier will be generated. This will drive the BGR to the desired operation point. At the same time, transistors MN8 and MN9 will be gradually on, which switches the supply current of MP5 to the self-biased current generated in the bandgap core. After the startup is completed, the startup current is not turned off for  $V_{REF}$  readjustment in the case of reference voltage falling for some reasons [11].





**Fig. 2** Schematic of proposed voltage reference

### SBCS Generator

There are two SBCS loops in the proposed BGR, which are helpful for performance enhancement [1]. The first one is located at the tail current of the amplifier. The PTAT current through transistor Q4 is mirrored into Q3. However, the current through Q4 is determined by the voltage across resistor R1, which is clamped to the input offset voltage of the amplifier. Due to the same aspect ratios of MP7 and MP8, the input offset voltage of the amplifier can be expressed as

$$V_{OS} = V_T \ln N \quad (1)$$

where  $N$  is the area ratio of Q1 and Q2, and  $V_T$  is the thermal voltage. Therefore, the current in amplifier and bandgap core parts is PTAT current, which can be given by

$$I_{R1} = V_T \ln N / R_1 \quad (2)$$

The current of bandgap reference core is mirrored into the amplifier as tail current, forming the first self-biased loop.

The second SBCS loop is made up with the current amplifier. The PTAT current shown in equation (2) is mirrored into the current amplifier by the current mirror of MP7 and MP6. Then the current,  $I$ , is amplified

by  $K$  as the current source to node VREF, which can be described as

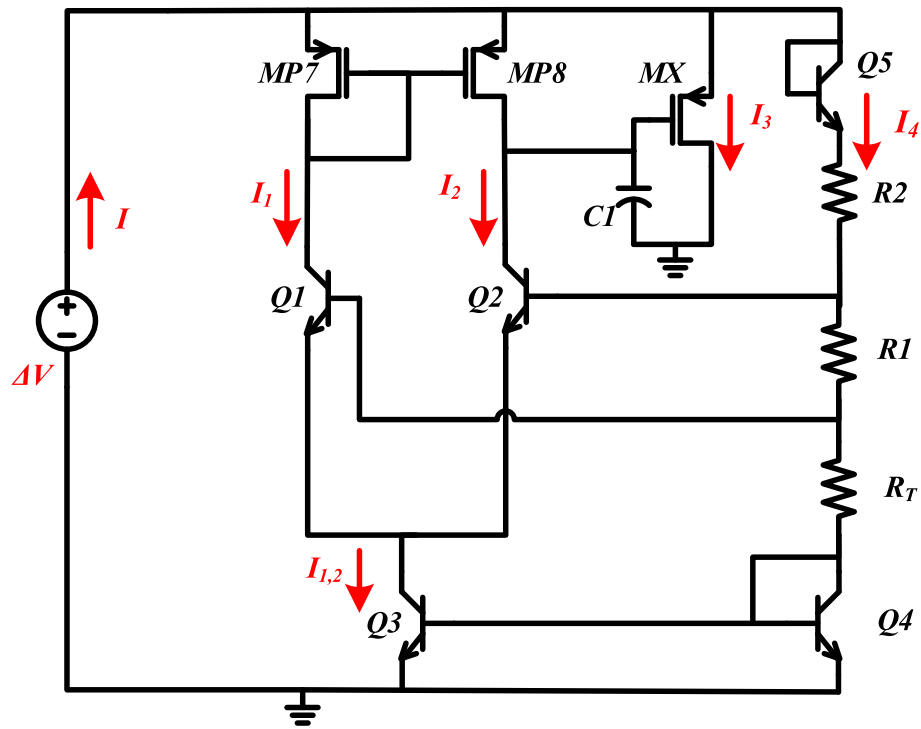
$$K = k_1 k_2 \quad (3)$$

where  $k_1 = S_{MN6}/S_{MN7}$ ,  $k_2 = S_{MP3}/S_{MP2}$ ,  $S_i$  is the aspect ratio of transistor  $i$ . Therefore, the current,  $KI$ , is reinjected into the amplifier and bandgap core parts, which constructs the second self-bias loop.

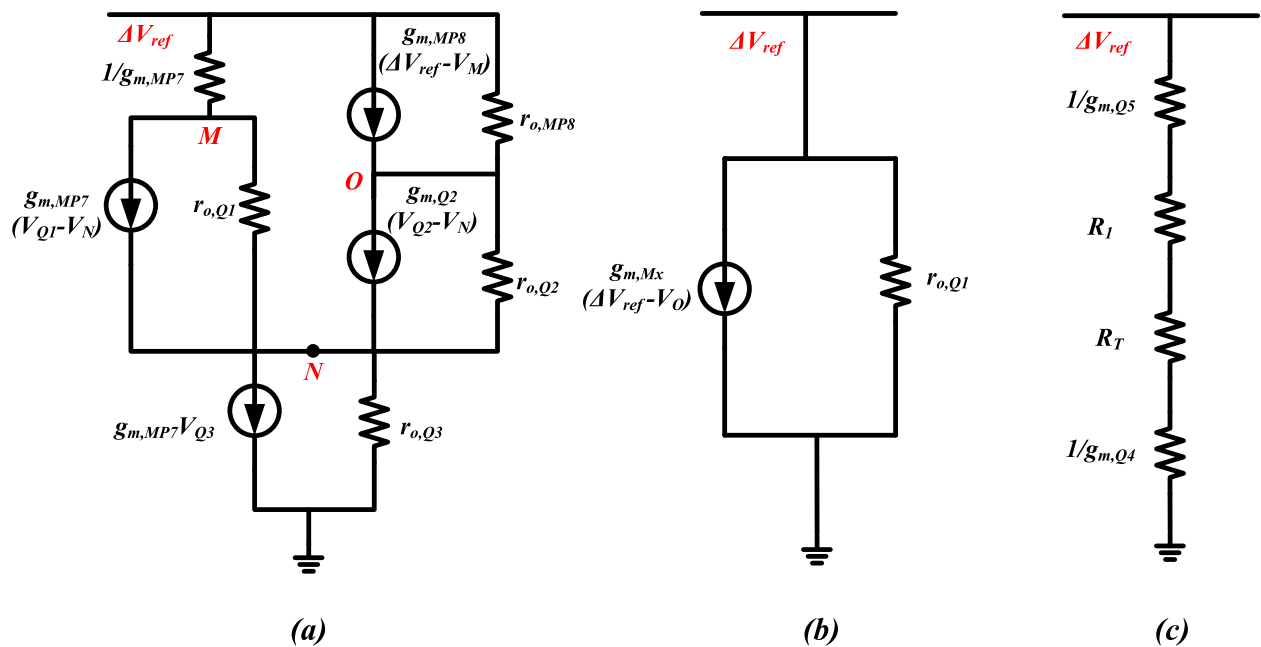
In order to guarantee the proper operation with low power consumption, the current,  $KI$ , should be slightly larger than the minimum current requirement of amplifier and bandgap core. In the proposed design, the currents through MP6, MP7, and MP8 are set at the same level,  $I$ . The current through bandgap core is  $2I$ . Therefore, the relationship,  $6 \geq K > 5$ , should be satisfied [12–14].

### $V_{REF}$ Generator Circuit

The  $V_{REF}$  generator circuit is shown in the right part of Fig. 2, which consists of an amplifier and bandgap core. As shown in equation (2), the PTAT offset voltage of the amplifier is multiplexed by the SBCS loops [15]. This makes the current through R1, R2, and  $R_{Trimming}$  is PTAT current, which is used as temperature compensation of the negative TC of Q4 and Q5. The generated reference voltage,  $V_{REF}$ , can be expressed as



**Fig. 3**  $R_{eq}$  calculation diagram



**Fig. 4** Small-signal model for  $R_{eq}$ . **a**  $R_{eq1,2}$  calculation diagram. **b**  $R_{eq3}$  calculation diagram. **c**  $R_{eq4}$  calculation diagram

$$V_{REF} = 2V_{BE} + \left(1 + \frac{R_2 + R_{Trim\ ming}}{R_1}\right) V_T \ln N \quad (4)$$

With the ratio adjustment of  $(R_2 + R_{Trim\ ming})/R_1$ , a temperature-compensated reference voltage can be realized with low-temperature drift.

### Feedback

A LNFL is established in the amplifier and bandgap core, which is formed by two small LNFLs. The first one, loop1, is from the input of the amplifier to  $V_{REF}$ , and feedback to the input of the amplifier. The other one, loop2, is from  $V_{REF}$  through Bandgap core to current tail of amplifier, and feedback to  $V_{REF}$ . For loop1, there are positive feedback and negative feedback double local loops with the input of the amplifier. The positive feedback loop is composed of Q5, R2, R1, Q1, MP8, and MX. The negative feedback loop consists of Q5, R2, Q2, and MX. The gain of the positive and negative feedback loop is derived as

$$A_{V,PF} = \frac{R_{Trim\ ming}}{R_1 + R_{Trim\ ming} + R_2} g_{m,Q1} r_{o,MP8} \quad (5)$$

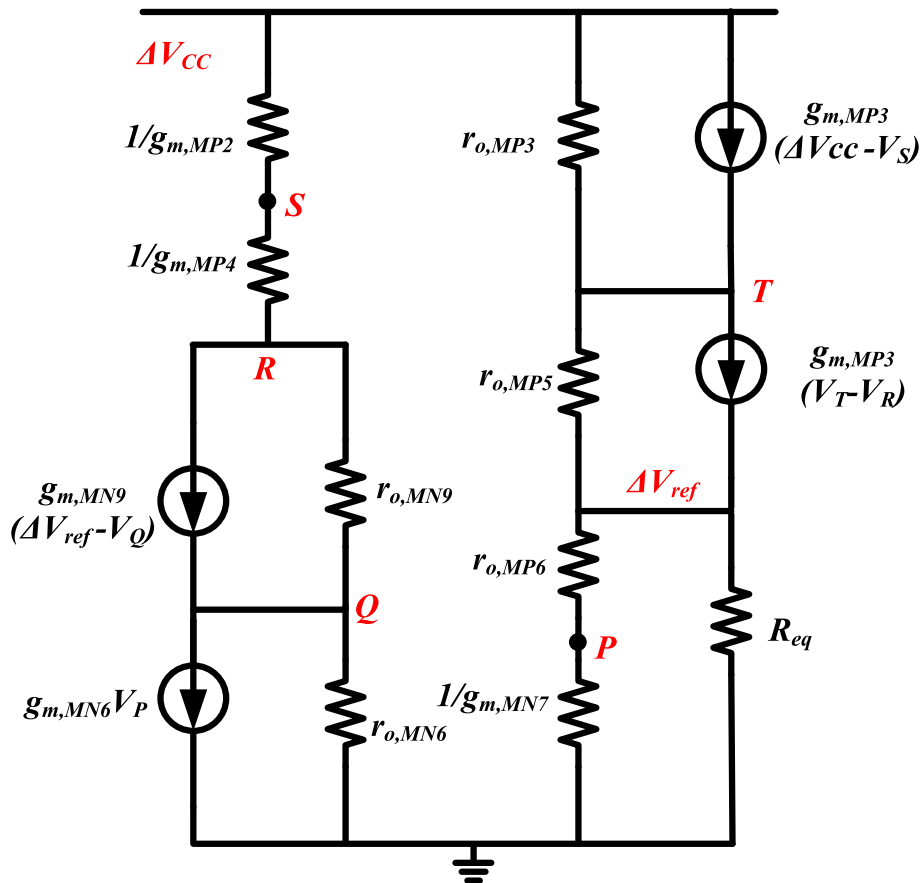
$$A_{V,NF} = \frac{R_1 + R_{Trim\ ming}}{R_1 + R_{Trim\ ming} + R_2} g_{m,Q2} r_{o,MP8} \quad (6)$$

where  $g_{m,Q1}$  is the transconductance of transistor Q1,  $r_{o,MP8}$  is the output resistance of transistor MP8, and the  $g_m$  of Q1 and Q2 is approximately equal. Since the effect of the negative feedback loop is stronger than that of the positive feedback loop, the loop1 behaves as a feedback loop, whose loop characteristic can be expressed as

$$T_{loop1} \approx \frac{R_1}{R_1 + R_{Trim\ ming} + R_2} g_{m,Q1} r_{o,MP8} \quad (7)$$

$$p_0 \approx \frac{1}{r_{o,MP8} C_1} \quad (8)$$

where  $p_0$  is the dominant pole. With regard to loop2, the performance can be given by



**Fig. 5** Small-signal model for PSRR

$$T_{\text{loop2}} \approx \frac{1/g_{m,MP8}}{R_1 + R_{\text{Trimming}} + R_2} \quad (9)$$

$$p_1 \approx \frac{g_{m,MP8}}{C_1} \quad (10)$$

where  $g_{m,MP8}$  is the transconductance of transistor MP8, and  $p_1$  is the dominant pole. As a result, the total loop gain of LNFL is

$$T_{\text{LNFL}} \approx \frac{R_1 g_{m,Q1} r_{o,MP8} + 1/g_{m,MP8}}{R_1 + R_{\text{Trimming}} + R_2} \frac{1 + s/z_0}{(1 + s/p_0)(1 + s/p_1)} \quad (11)$$

Taken equation (2) into consideration, equation (11) can be rewritten as,

$$T_{\text{LNFL}} \approx \frac{r_{o,MP8} \ln N + 1/g_{m,MP8}}{R_1 + R_{\text{Trimming}} + R_2} \frac{1 + s/z_0}{(1 + s/p_0)(1 + s/p_1)} \quad (12)$$

where  $z_0 \approx g_{m,MP8}/[C_1(1 + 1/\ln N)]$ . Since  $N = 8$  in the proposed design, it makes the zero,  $z_0$ , proximately equal to twice the pole,  $p_1$ , which can extend the loop bandwidth of LNFL by twice.

A GSBL is formed by the current amplifier, bandgap core, and amplifier, which can provide bias current for

the whole circuit in a self-biased method with enhanced PSRR performance. The loop gain of GSBL can be given by

$$T_{\text{GSBL}} \approx \frac{K \left( 1/3g_{m,MP8} \parallel 1/g_{m,MX} \right)}{R_1 + R_{\text{Trimming}} + R_2} \quad (13)$$

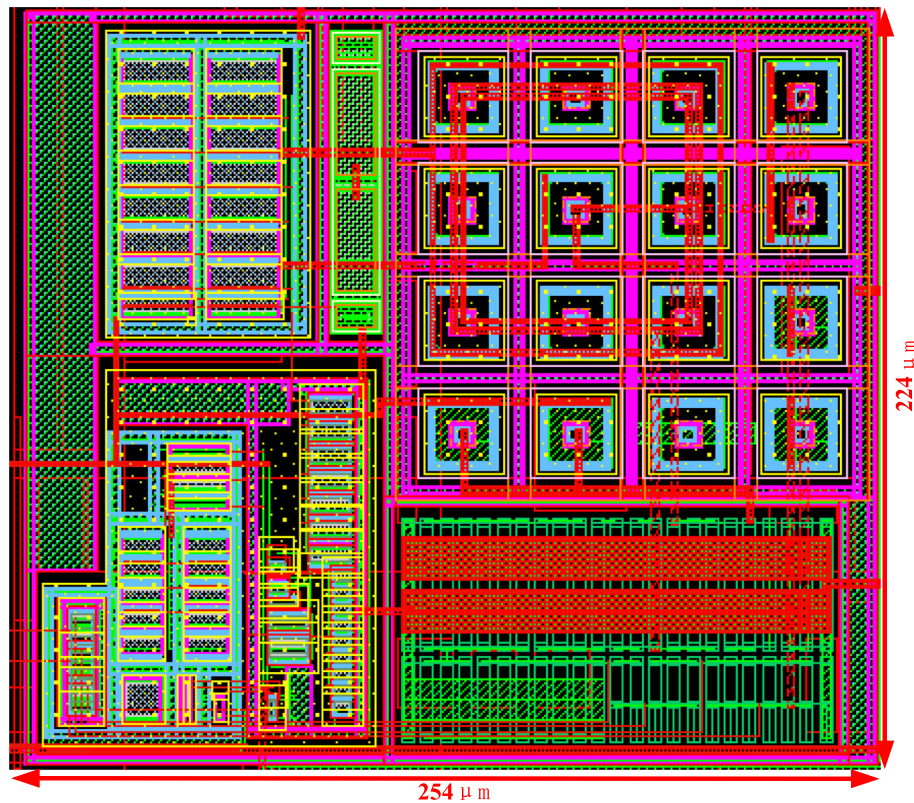
where  $g_{m,MX}$  is the transconductance of transistor  $M_X$ . The main effect of transistor  $M_X$  is to lower the equivalent impedance at  $V_{\text{REF}}$  with the convenience of loop compensation.  $T_{\text{GSBL}}$  is set to be smaller than one in the proposed design, which can avoid oscillation.

With the help of LNFL and GSBL, the stability of generated reference voltage,  $V_{\text{REF}}$ , can be greatly improved.

### PSRR of Proposed Voltage Reference

In order to simplify the PSRR calculation of the proposed circuit, the equivalent resistance of the part powered by the reference voltage,  $V_{\text{REF}}$ , is firstly calculated. The calculation diagram of this part is shown in Fig. 3 [16].

Figure 4a shows a small-signal model for the equivalent resistance calculation of circuit branches 1, 2, where currents  $I_1$  and  $I_2$  flow in Fig. 3, respectively. Then, the equivalent resistance,  $R_{eq1,2}$ , can be expressed as



**Fig. 6** Layout of proposed circuit



$$R_{eq1,2} \approx \frac{3R_{eq4}r_{o,Q1}}{3g_{m,Q1}r_{o,Q1}(R_T + R_1 + r_{o,Q3}) + g_{m,Q1}R_1r_{o,Q1} + 3R_{eq4}} \quad (14)$$

where  $g_{m,Q1}$  and  $r_{o,Q1}$  are transconductance and output resistance of Q1, respectively;  $R_{eq4}$  is equivalent resistance of branch with  $I_4$ . Since the gate voltage of MP6 shown in Fig. 2 is determined by the drain voltage of MP7, the power supply noise attenuation (PSNA) at node M should be also calculated, which can be given by

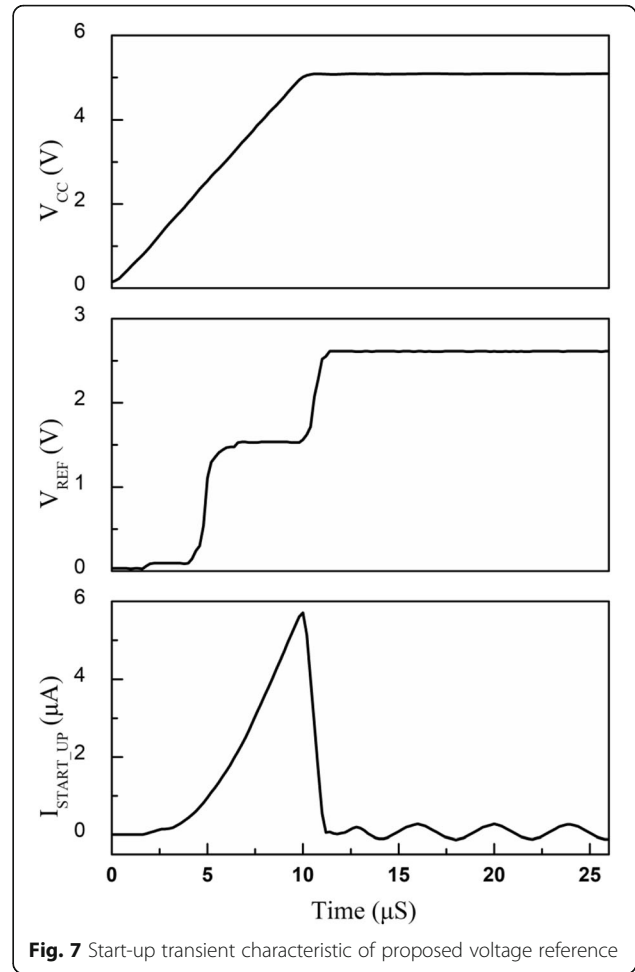
$$V_M = \Delta V_{ref} + \frac{g_{m,Q1}R_1r_{o,Q2}}{2g_{m,MP7}(r_{o,Q2} + r_{o,MP8})R_{eq4}} \Delta V_{ref} \approx \Delta V_{ref} \quad (15)$$

where  $r_{o,MP8}$  and  $r_{o,Q2}$  are output resistance of MP8 and Q2, respectively;  $g_{m,MP7}$  is transconductance of MP7. As claimed in equation (15), the supply noise has little influence on the source-gate voltage of MP6. This makes MP6 act as a high impedance,  $r_{o,MP6}$ , which separates the noise impacts from the amplifier and bandgap core parts.

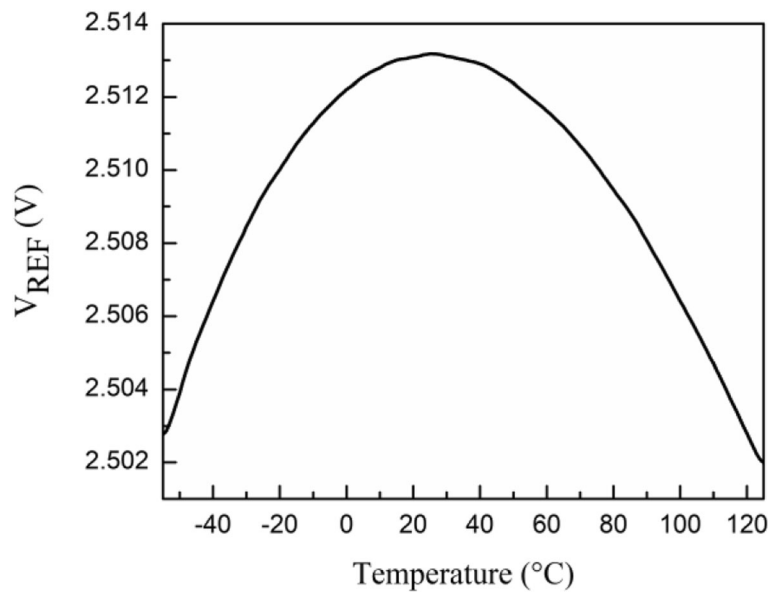
The equivalent resistance of branch with  $I_3$  in Fig. 3 can be derived by Fig. 4b, which can be expressed as

$$R_{eq3} \approx \frac{6R_{eq4}}{g_{m,mx} [3g_{m,Q1}r_{o,Q1}(R_T + R_1 + r_{o,Q3}) + 3R_{eq4} + g_{m,Q1}r_{o,Q1}R_1]} \quad (16)$$

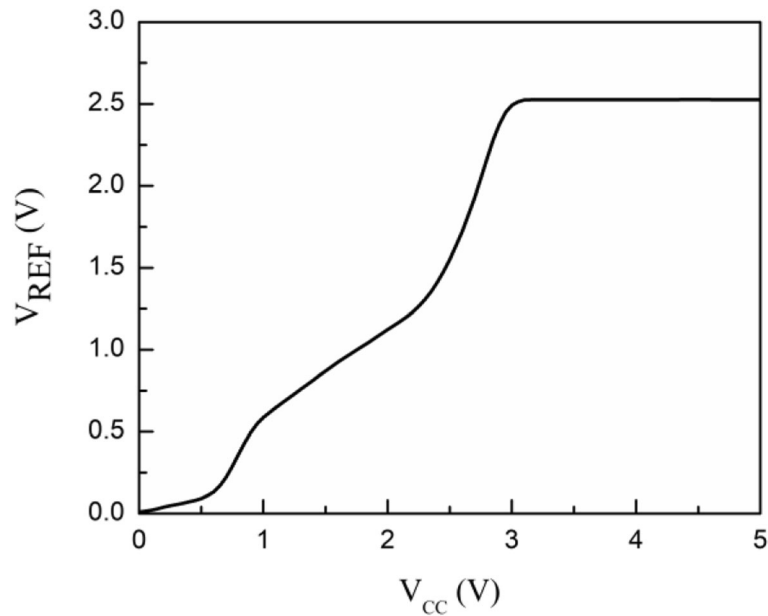
where  $g_{m,Mx}$  is the transconductance of Mx. The small-



**Fig. 7** Start-up transient characteristic of proposed voltage reference



**Fig. 8** Temperature dependence of generated reference voltage



**Fig. 9** Supply dependence of generated reference voltage

signal model of equivalent resistance of branch with  $I_4$  in Fig. 3 is shown in Fig. 4c, which is,

$$R_{eq4} \approx 1/g_{m,Q5} + R_1 + R_T + 1/g_{m,Q4} + R_2 \quad (17)$$

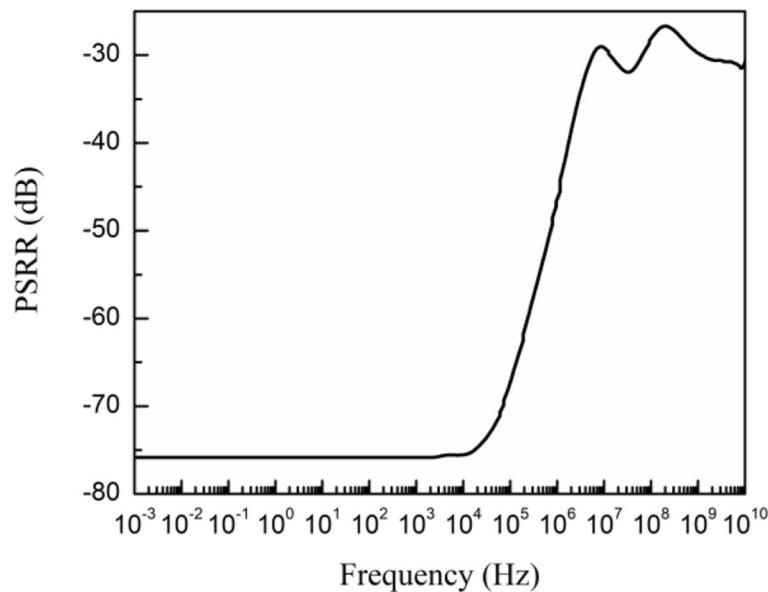
Therefore, the small-signal equivalent resistance of amplifier and bandgap core parts in Fig. 3 is

$$R_{eq} = R_{eq1,2} \parallel R_{eq3} \parallel R_{eq4} \quad (18)$$

Therefore, the total PSRR of the proposed voltage reference can be illustrated in Fig. 5. The PSRR can be given by

$$\frac{\Delta V_{ref}}{\Delta V_{CC}} \approx \frac{6R_{eq,4}}{g_{m,mx}g_{m,mp3}r_{o,mp3}r_{o,mp6} [3g_{m,Q1}r_{o,Q1}(R_T + R_1 + r_{o,Q3}) + 3R_{eq,4} + g_{m,Q1}r_{o,Q1}R_1]} \quad (19)$$

Since  $g_m r_o \gg 1$  is generally valid, the influence of power supply noise on the generated reference voltage is greatly suppressed.



**Fig. 10** PSRR characteristic of proposed voltage reference



**Table 1** Performance of reference voltage with process variations

Parameter results	$V_{REF}$ (V)	TC (ppm/°C)	LS (%/V)	PSRR@10 Hz (dB)
Minimum value	2.484	24	0.02	-71
Typical value	2.506	25	0.08	-76
Maximum value	2.522	30	0.12	-78

## Results and Discussion

The voltage reference is implemented in a 180 nm BCD process, whose layout is shown in Fig. 6, occupying a  $0.05690 \text{ mm}^2$  active area.

The simulated start-up waveforms are shown in Fig. 7, which illustrates the transient procedure with the power-supply-voltage establishment. When the supply voltage is small, the entire reference circuit is not fully operated, which means the startup branch current is very small and the reference voltage is maintained at zero. With the rising of power supply voltage, the generated reference voltage is firstly stable at approximately  $2V_{BE}$  due to the abnormal operation of the amplifier part in Fig. 2. When the supply voltage increases above the minimum required supply voltage of proposed BGR, the core operational amplifier starts to work, and the reference voltage is quickly stabilized at the desired value. Besides, the start-up current drops about to zero with a desired reference voltage, while the proposed SBSCS taking the place of current supply with the GSBL. The power consumption of start-up circuit accounts for a small part of that of the chip.

The temperature characteristics of the generated reference voltage,  $V_{REF}$ , are shown in Fig. 8. The voltage variation of  $V_{REF}$  in the range of  $-55^\circ\text{C} \sim 125^\circ\text{C}$  is 11.3 mV, where a TC of 25 ppm/°C is achieved.

Figure 9 demonstrates the line sensitivity (LS) of the reference output voltage. The proposed BGR can be successfully established over 3 V supply voltage, and  $V_{REF}$  variation is 0.2 mV within 3–5 V supply voltage. This means a good LS of 0.08%/V is realized.

The improved PSRR performance is illustrated in Fig. 10, which has a PSRR of 76 dB agreeing with theoretical results in equation (19) at low frequencies and above 46 dB up to 1 MHz.

Conventional binary trimming method is suitable for the proposed BGR, which adopts an 8-bit trimming for  $R_{Trimming}$ . This can realize a 9 mV/LSB trimming step. Table 1 shows the performance of trimmed voltage reference with 3–5 V supply voltage and  $-55$  to  $125^\circ\text{C}$  temperature range under difference process corners, which include typical, slow, and fast cases. As shown in Table 1, the temperature drift is within 0.6%, the LS is below 0.12%/V, and PSRR is above 71 dB@10 Hz.

Table 2 gives the characteristic summary of the proposed voltage reference and the comparison with some previously reported voltage references. Since the proposed voltage reference is aiming at high supply stability, no high-order temperature compensation is utilized in this paper. Therefore, the TC of [11–13], which mainly focus on temperature or power optimization methods, is smaller than that of the proposed voltage reference. The TC of the proposed voltage reference can be further optimized with literature reported curvature-compensation methods as needed. With the proposed compacted structure, LNFL and GSBL are realized with a temperature-independent reference voltage at the same time, which has the best PSRR and LS performance in Table 2.

## Conclusion

A compacted self-biased BGR with high PSRR is presented in this paper. The PTAT voltage is implemented by an operational amplifier with asymmetrical input offset voltage, and the negative temperature voltage is superimposed to generate a reference output voltage. At the same time, two feedback loops, LNFL and GSBL, are realized with the same parts for temperature stability, which reduces the structural complexity. This leads to self-sufficiency of supply current and power supply sensitivity improvement with high PSRR.

**Table 2** Performance summary and comparison

	This work	[17]	[18]	[19]	[20]
Process (nm)	180	350	180	180	180
Minimum supply voltage (V)	3	2	1.4	0.9	0.8
Power (W)	45 $\mu$	66 $\mu$	34p	85n	79n
Temperature range (°C)	-55-125	-40-125	0-100	-40-125	10-100
$V_{REF}$ (V)	2.506	1.141	1.250	0.412	0.328
TC (ppm/°C)	25	1.01	23	33.7	33.8
PSRR@10 Hz (dB)	-76	-61	-42.2	-61	-55
LS (%/V)	0.08	2	2.5	0.6	2.1

**Abbreviations**

BGR: Bandgap reference; PSRR: Power supply rejection ratio; TC: Temperature coefficient; PTAT: Proportional to absolute temperature; LNFL: Local negative feedback loop

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Not applicable.

**Authors' Contributions**

Yue Shi proposed the novel structure and was a major contributor in writing the manuscript. Shilei Li verified the theory with simulation and was a contributor in writing the manuscript. Jianwen Cao improved the design of the circuit. Other authors offered comments and revised the manuscript. All authors read and approved the final manuscript.

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**Availability of Data and Materials**

All data generated or analyzed during this study are included in this published article.

**Competing Interests**

The authors declare that they have no competing interests.

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